Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/982,587	FUJII ET AL.	
Examiner	Art Unit	
Mark Ruthkosky	1745	

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Class	Subclass	Date	Examiner
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429	35, 36		
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
429	36, 39	12/05	M
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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